## Freescale Semiconductor

Technical Data

MC14578 Rev 2, 05/2005

Archive Information

# CMOS Micro-Power Comparator plus Voltage Follower

The MC14578 is an analog building block consisting of a very-high input impedance comparator. The voltage follower allows monitoring the noninverting input of the comparator without loading.

Four enhancement-mode MOSFETs are also included on chip. These FETs can be externally configured as open-drain or totem-pole outputs. The drains have on-chip static-protecting diodes. Therefore, the output voltage must be maintained between  $V_{SS}$  and  $V_{DD}$ .

The chip requires one external component. A 3.9 M $\Omega$  ±10% resistor must be connected from the R<sub>bias</sub> pin to V<sub>DD</sub>. This circuit is designed to operate in smoke detector systems that comply with UL217 and UL268 specifications.

## **Features**

Applications:

Pulse Shapers Line-Powered Smoke Detectors

Threshold Detectors Liquid/Moisture Sensors

Low-Battery Detectors CO Detector and Micro Interface

· Operating Voltage Range: 3.5 to 14 V

Operating Temperature Range: -30° to 70°C

Input Current (IN + Pin): ±1 pA @ 25°C (DIP Only)

Quiescent Current: 10 μA @ 25°C

Electrostatic Discharge (ESD) Protection Circuitry on All Pins

ORDERING INFORMATION				
Device Temperature Range		Case No.	Package	
MC14578P	-30° to 70°C	648-08	Plastic Dip	

# MC14578

CMOS
MICRO-POWER COMPARATOR
PLUS VOLTAGE FOLLOWER



P SUFFIX PLASTIC DIP CASE 648-08

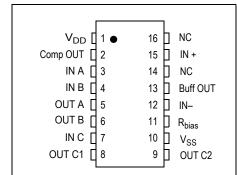


Figure 1. Pin Connections



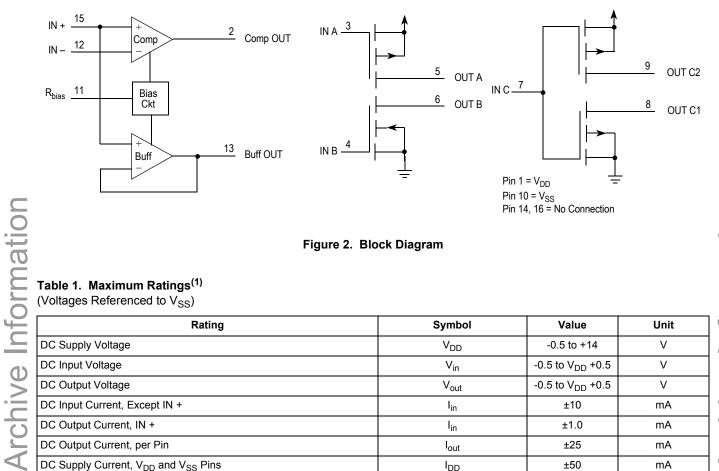


Figure 2. Block Diagram

Table 1. Maximum Ratings<sup>(1)</sup> (Voltages Referenced to V<sub>SS</sub>)

Rating	Symbol	Value	Unit
DC Supply Voltage	$V_{DD}$	-0.5 to +14	V
DC Input Voltage	V <sub>in</sub>	-0.5 to V <sub>DD</sub> +0.5	V
DC Output Voltage	V <sub>out</sub>	-0.5 to V <sub>DD</sub> +0.5	V
DC Input Current, Except IN +	I <sub>in</sub>	±10	mA
DC Output Current, IN +	I <sub>in</sub>	±1.0	mA
DC Output Current, per Pin	I <sub>out</sub>	±25	mA
DC Supply Current, V <sub>DD</sub> and V <sub>SS</sub> Pins	I <sub>DD</sub>	±50	mA
Power Dissipation, per Package	P <sub>D</sub>	500	mW
Storage Temperature	T <sub>stg</sub>	-65 to + 150	°C
Lead Temperature (10-Second Soldering)	TL	260	°C

<sup>1.</sup> Maximum Ratings are those values beyond which damage to the device may occur. This device contains protection circuitry to guard against damage due to high static voltages or electric fields. However, precautions must be taken to avoid applications of any voltage higher than  $V_{out}$ )  $\leq V_{DD}$ . Unused inputs must always be tied to an appropriate logic voltage level (e.g., either  $V_{SS}$  or  $V_{DD}$ ). Unused outputs must be left

## **Table 2. Electrical Characteristics**

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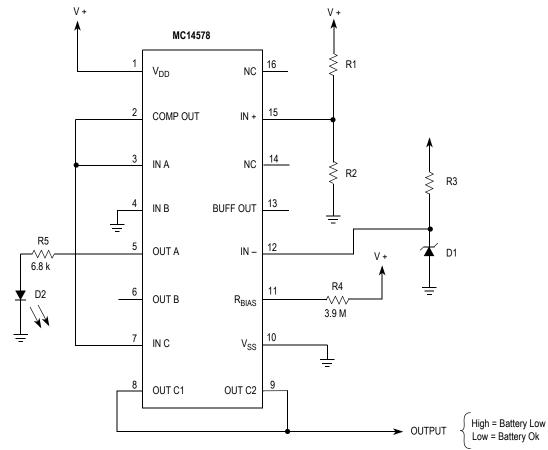
(Voltages Referenced to V<sub>SS</sub>, R<sub>bias</sub> = 3.9 M $\Omega$  to V<sub>DD</sub>, T<sub>A</sub> = -30 $^{\circ}$  to 70 $^{\circ}$ C Unless Otherwise Indicated)

Characteristic	Symbol	Test Condition	V <sub>DD</sub> V <sub>DC</sub>	Guaranteed Limit	Unit
Power Supply Voltage Range	$V_{DD}$		_	3.5 to 14.0	V
Maximum Low-Level Input Voltage, MOSFETs Wired as Inverters; i.e., IN A tied to IN B, OUT A to OUT B, OUT C1 to OUT C2	V <sub>IL</sub>	V <sub>out</sub> = 9.0 V, II <sub>out</sub> I <1 μA	10.0	2.0	V
Minimum High-Level Input voltage, MOSFETs Wired as Inverters; i.e., IN A tied to IN B, OUT A to OUT B, OUT C1 to OUT C2	V <sub>IH</sub>	V <sub>out</sub> = 1.0 V, II <sub>out</sub> I <1 μA	10.0	8.0	V
Comparator Input Offset Voltage	V <sub>IO</sub>	T <sub>A</sub> = 25°C, Over Common Mode Range	10.0	±50 r	
		T <sub>A</sub> = 0° to 50°C, Over Common Mode Range	3.5 to 14.0	±75	
Comparator Common Mode Voltage Range	V <sub>CM</sub>		3.5 to 14.0	0.7 to V <sub>DD</sub> – 1.5	V
Maximum Low-Level Comparator Output Voltage	V <sub>OL</sub>	$\begin{aligned} &\text{IN +: V}_{\text{in}} = \text{V}_{\text{SS}}, &\text{IN -: V}_{\text{in}} = \text{V}_{\text{DD}}, \\ &\text{I}_{\text{out}} = 30 \; \mu\text{A} \end{aligned}$	10.0	0.5	V
Minimum High-Level Comparator Output Voltage	V <sub>OH</sub>	$\begin{split} &\text{IN +: V}_{\text{in}} = \text{V}_{\text{DD}}, \text{ IN -: V}_{\text{in}} = \text{V}_{\text{SS}}, \\ &\text{I}_{\text{out}} = -30  \mu\text{A} \end{split}$	10.0	9.5	V
Buffer Amp Output Offset Voltage	V <sub>oo</sub>	$R_{load}$ = 10 M $\Omega$ to $V_{DD}$ or $V_{SS}$ , Over Common Mode Range	_	±100	mV
Maximum Low-Level Input Voltage, MOSFETs	V <sub>OL</sub>	OUT C1, OUT C2, I <sub>out</sub> = 1.1 mA	10.0	0.5	V
Wired as Inverters; i.e., IN A tied to IN B, OUT A to OUT B, OUT C1 to OUT C2		OUT A, OUT B, I <sub>out</sub> = 270 μA	10.0	0.5	V
Minimum High-Level Input Voltage, MOSFETs	V <sub>OH</sub>	OUT C1, OUT C2, I <sub>out</sub> = -1.1 mA	10.0	9.5	V
Wired as Inverters; i.e., IN A tied to IN B, OUT A to OUT B, OUT C1 to OUT C2		OUT A, OUT B, I <sub>out</sub> = 270 μA	10.0	9.5	V
Maximum Input Leakage IN + (DIP Only) Current	I <sub>in</sub>	T <sub>A</sub> = 25°C, 40% R.H., V <sub>in</sub> = V <sub>SS</sub> or V <sub>DD</sub>	10.0	±1.0	pA
IN + (DIP Only)		$T_A = 50$ °C, $V_{in} = V_{SS}$ or $V_{DD}$	10.0	±6.0	
IN + (SOG), IN A, IN B, IN C, IN -		$V_{in} = V_{SS}$ or $V_{DD}$	10.0	±40	nA
Maximum Off-State MOSFET Leakage Current	I <sub>OZ</sub>	IN A, IN C: V <sub>in</sub> = V <sub>DD</sub> , OUT A, OUT C2: V <sub>out</sub> = V <sub>SS</sub> or V <sub>DD</sub>	10.0	±100	nA
		IN B, IN C: V <sub>in</sub> = V <sub>SS</sub> , OUT B, OUT C1: V <sub>out</sub> = V <sub>SS</sub> or V <sub>DD</sub>	10.0	±100	
Maximum Quiescent Current	I <sub>DD</sub>	$\begin{split} T_A &= 25^{\circ}C\\ \text{IN A, IN B, IN C: V}_{\text{in}} &= \text{V}_{\text{SS}} \text{ or V}_{\text{DD}},\\ \text{IV}_{\text{IN}} &+ -\text{V}_{\text{IN}} - \text{I} = 100 \text{ mV}\\ \text{I}_{\text{out}} &= 0  \mu\text{A} \end{split}$	10.0	10	μА
Maximum Input Capacitance IN + Other Inputs	C <sub>in</sub>	f = 1 kHz	_ _	5.0 15	pF

Low-battery

Indicator

## **APPLICATIONS INFORMATION**



NOTE: IN + and IN - have very high input impedance. Interconnect to these pins should be as short as possible.

Figure 3. Low-Battery Detector

## **EXAMPLE VALUES**

Near the switchpoint, the comparator output in the circuit of Figure 3. may chatter or oscillate. This oscillation appears on the signal labelled OUTPUT. In some cases, the oscillation in the transition region will not cause problems. For example, an MPU reading OUTPUT could sample the signal two or three times to ensure a solid level is attained. But, in a low battery detector, this probably is not necessary.

To eliminate comparator chatter, hysteresis can be added as shown in Figure 4. The circuit of Figure 4. requires slightly more operating current than the Figure 3. arrangement.

R1	R2	R3	Nominal Tip Point
470 kΩ	1.3 MΩ	20 kΩ	4.08 V
820 kΩ	1.2 MΩ	39 kΩ	5.05 V
1.2 MΩ	1.2 MΩ	62 kΩ	6.00 V

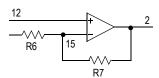
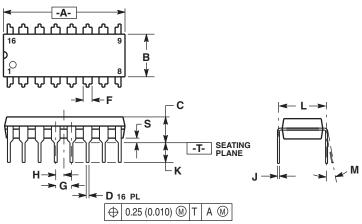


Figure 4. Adding Hysteresis

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## **PACKAGE DIMENSIONS**



STYLE 1:		STYLE 2:	
PIN 1.	CATHODE	PIN 1.	COMMON DI
2.	CATHODE	2.	COMMON DI
3.	CATHODE	3.	COMMON DI
4.	CATHODE	4.	COMMON DI
	CATHODE		COMMON DI
	ANODE		GATE
	ANODE		SOURCE
	ANODE		GATE
	ANODE		SOURCE
	ANODE		GATE
	ANODE		SOURCE
	ANODE	15.	GATE
16	ANODE	16	SOURCE

**CASE 648-08 ISSUE R 16-LEAD PLASTIC DIP** 

- DIMENSIONING AND TOLERANCING PER ANSI
- DIMENSIONING AND TOLEHANGING PEH AN Y14.5M, 1982. CONTROLLING DIMENSION: INCH. DIMENSION L TO CENTER OF LEADS WHEN FORMED PARALLEL.
- 4. DIMENSION B DOES NOT INCLUDE MOLD FLASH.
  5. ROUNDED CORNERS OPTIONAL.

	INC	HES	MILLIM	IETERS	
DIM	MIN	MAX	MIN	MAX	
Α	0.740	0.770	18.80	19.55	
В	0.250	0.270	6.35	6.85	
С	0.145	0.175	3.69	4.44	
D	0.015	0.021	0.39	0.53	
F	0.040	0.70	1.02	1.77	
G	0.100 BSC		2.54 BSC		
Н	0.050	BSC	1.27	BSC	
J	0.008	0.015	0.21	0.38	
K	0.110	0.130	2.80	3.30	
L	0.295	0.305	7.50	7.74	
M	0	10	0	10	
S	0.020	0.040	0.51	1.01	

# NOTES

# NOTES

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